

Search Notes

Application/Control No.

10/829,267

Examiner

Tuan T. Nguyen

Applicant(s)/Patent under
Reexamination

KONDO, YOSHIHISA

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	233	7/25/2005	<i>Pu</i>
	185.17		
	230.06		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	233	7/25/2005	<i>Pu</i>
	185.17		
	230.06		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (all Databases, see search history printout)	7/25/2005	<i>Pu</i>
365/185.17, 233, 230.06 (USPAT only, see history printout)		
interference search (text only, see history printout))		
inventor's name search (see history printout))		
Consulted Primary Examiner Son Dinh		